

Product Change Notification / JAON-24XWVA797

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26-Oct-2021

Product Category:

Memory

PCN Type:

Manufacturing Change

Notification Subject:

CCB 4823 Final Notice: Qualification of MTAI as an additional final test site for selected SST26VF064B, and SST26VF064BA device families available in 16L SOIC (0.300in) package.

Affected CPNs:

JAON-24XWVA797_Affected_CPN_10262021.pdf JAON-24XWVA797_Affected_CPN_10262021.csv

Notification Text:

PCN Status: Final notification.

PCN Type: Manufacturing Change

Microchip Parts Affected:Please open one of the files found in the Affected CPNs section

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

Description of Change:Qualification of MTAI as an additional final test site for selected SST26VF064B, and SST26VF064BA device families available in 16L SOIC (0.300in) package.

Pre and Post Change Summary:

	Pre Change Post Change		nange
Final Test Site	King Yuan Electronics	King Yuan	Microchip
	Company, Limited	Electronics	Technology
	(KYE)	Company, Limited	Thailand

			(KYE)	(HQ) (MTAI)	
Base Quantity	Tape and Reel	1000	1000	1000	
Multiple (BQM)	Tube	47	47	47	
Pin Orientation	Tape and Reel	Quadrant 1	Quadrant 1	Quadrant 1	
Pin Orientation	Tube	See pre and post change comparison.			
Carrier ta	ape	No dimensional changes. See pre and post change comparison.			
Cover Ta	ipe	Minor dimensional changes. See pre and post change comparison.			
Plastic R	eel	Minor dimensional changes. See pre and post change comparison.			
Packing Me	Packing Method See pre and post change comparison.			ison.	

Impacts to Data Sheet: None

Change Impact:None

Reason for Change:To improve manufacturability and on-time delivery performance by qualifying MTAI as an additional final test site.

Change Implementation Status:In Progress

Estimated First Ship Date: November 05, 2021 (date code: 2145)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

Time Table Summary:

Od			October 2021				Nove	mber	2021	l
Workweek	40	41	42	43	44	45	46	47	48	49
Initial PCN Issue Date	Χ									
Qual Report Availability					Х					
Final PCN Issue Date					Х					
Estimated Implementation Date						Х				

Method to Identify Change: Traceability code

Qualification Report:Please open the attachments included with this PCN labeled as PCN_#_Qual_Report.

Revision History:October 1, 2021: Issued initial notification. **October 4, 2021:** Re-issued initial notification with updated qualification plan. **October 26, 2021:** issued final notification. Attached the qualification report. Provided estimated first ship date to be on November 05, 2021.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

Attachments:

PCN_JAON-24XWVA797_Qual Report.pdf PCN_JAON-24XWVA797_Pre and Post Change_Summary.pdf

Please contact your local Microchip sales office with questions or concerns regarding this notification.

Terms and Conditions:

If you wish to <u>receive Microchip PCNs via email</u> please register for our PCN email service at our <u>PCN</u> home page select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the <u>PCN FAQ</u> section.

If you wish to <u>change your PCN profile</u>, <u>including opt out</u>, please go to the <u>PCN home page</u> select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

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Affected Catalog Part Numbers (CPN)

SST26VF064B-104I/SO

SST26VF064BA-104I/SO

SST26VF064B-104V/SO

SST26VF064BT-104V/SO

SST26VF064BT-104I/SO

SST26VF064BAT-104I/SO

Date: Monday, October 25, 2021

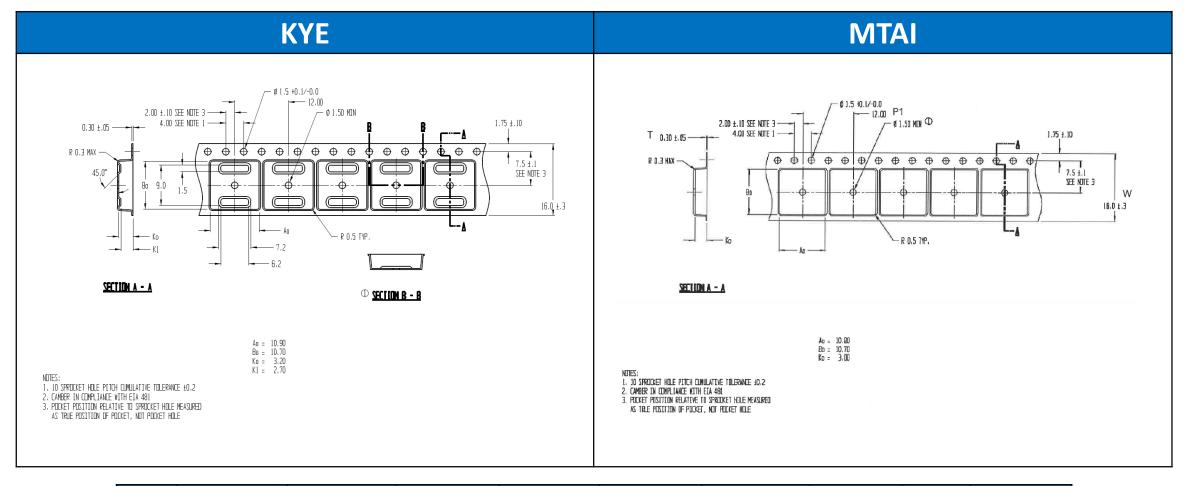
CCB 4823 Pre and Post Change Summary PCN# JAON-24XWVA797



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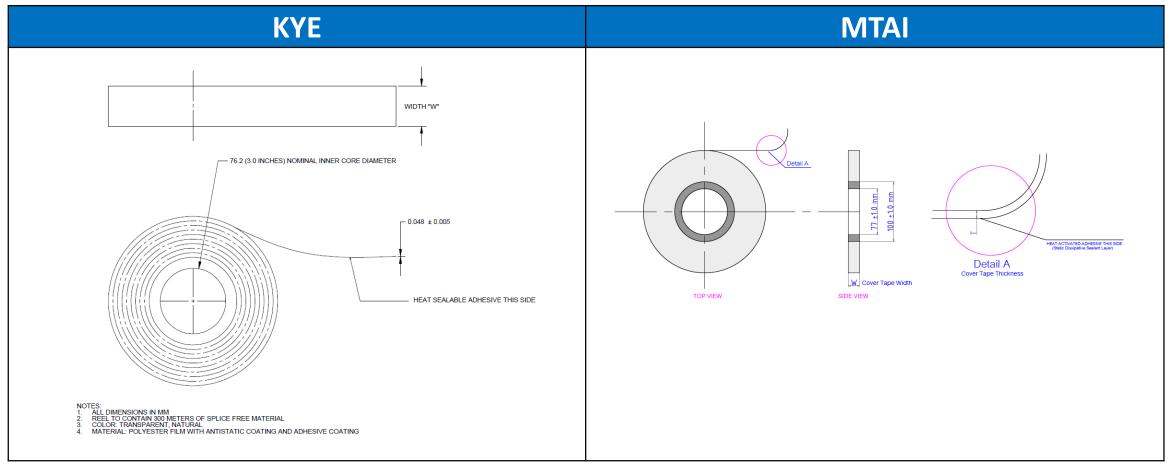
Pre and Post Change Summary – Carrier Tape



Plant	W (mm.)	P (mm.)	A0 (mm.)	B0 (mm.)	K0 (mm.)	K1 (mm.)	Thickness	BQM	Pin1
MTAI	16.00 ±0.30	12.00 ±0.10	10.90 ±0.10	10.70 ±0.10	3.00 ±0.10	-	0.30±0.05	1000	Quadrant 1
KYE	16.00±0.30	12.00±0.10	10.90±0.10	10.70±0.10	3.20±0.10	2.70±0.10	0.30±0.05	1000	Quadrant 1



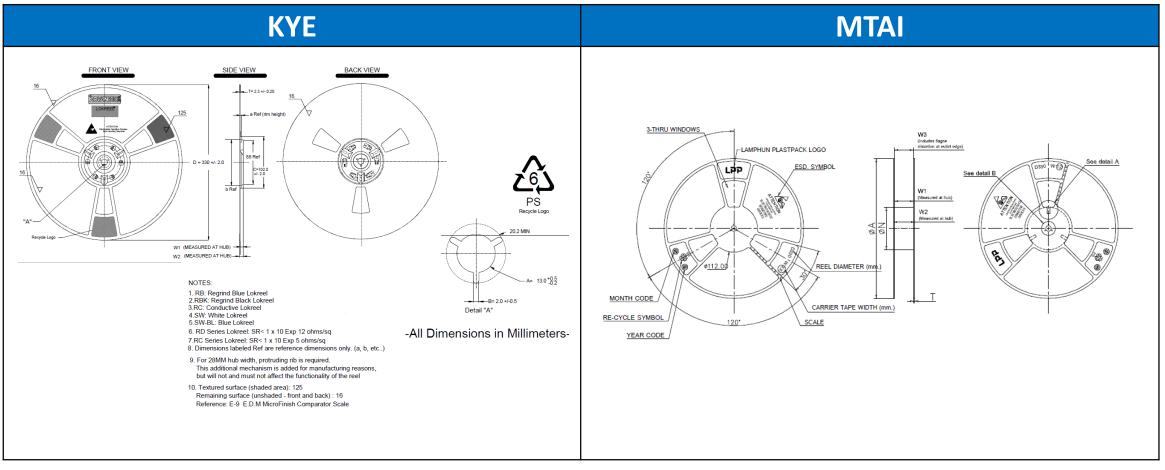
Pre and Post Change Summary – Cover Tape



Plant	Width W (mm.)	Thickness T (mm.)	Color	Sealing Methodology
MTAI	13.3 ± 0.1	0.050 ±0.010	Clear	Heat Seal
KYE	13.3±0.1	0.048 ±0.005	Clear	Heat Seal



Pre and Post Change Summary – Plastic Reel



Plant	Reel Diameter (mm.)	Reel Hub Size (mm)	Reel Width Max (mm.)	Color
MTAI	330 ±2.0	100 ±2.0	22.40	Dark Blue
KYE	330 ±2.0	102±2.0	8.4+0.3/-0.2 + 8.4+0.3/-0.2	Regrind Blue



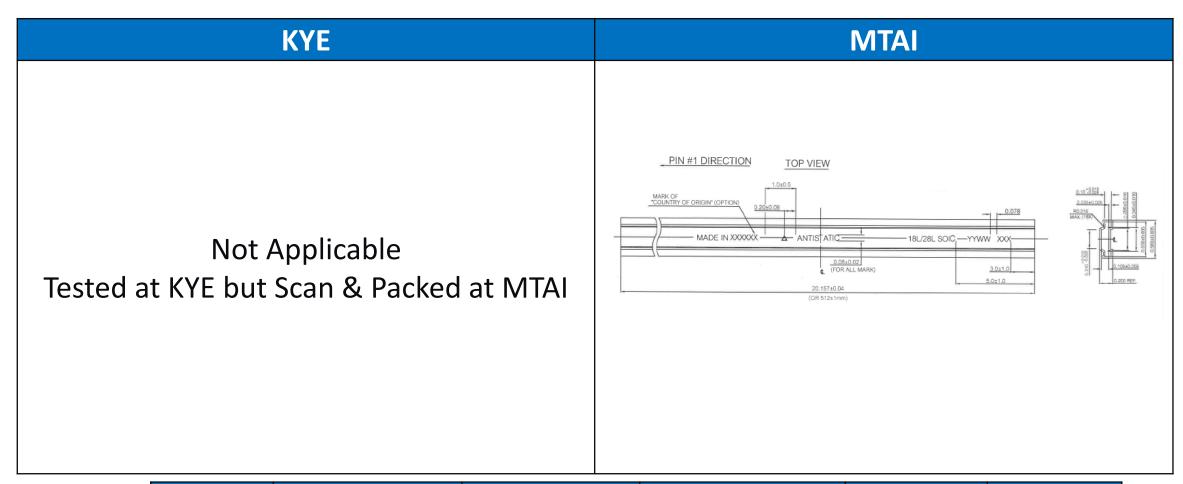
Pre and Post Change Summary – Tape and Reel Packing Method

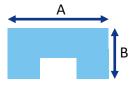


Plant	MSL Level	Desiccant	Humidity Indicator Card	Baking Condition
MTAI	MSL-3	2 units	1 pcs	4 hours @125°C
KYE	MSL-3	2 units	1 pcs	4 hours @ 125°C



Pre and Post Change Summary – Tube

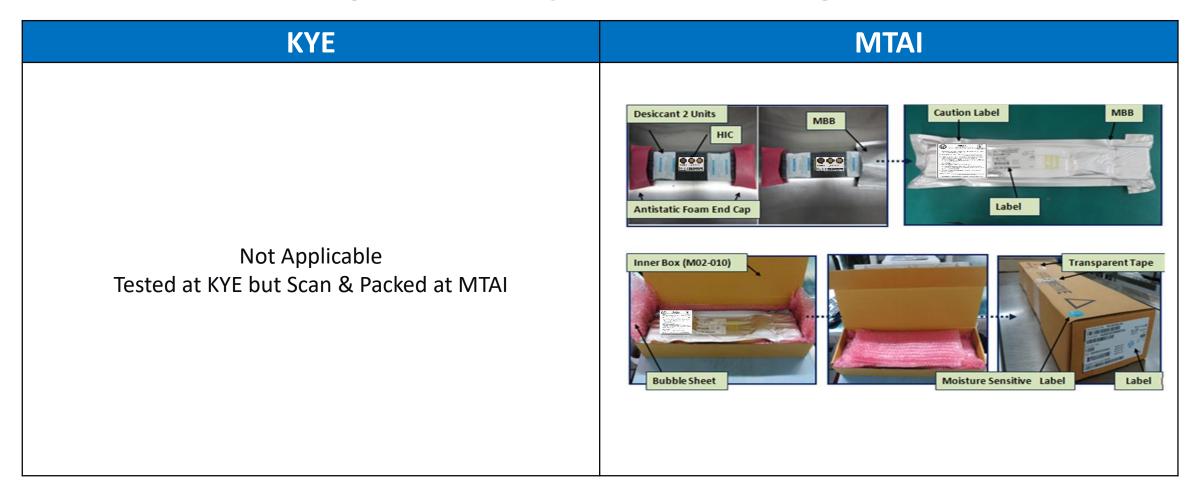




Plant	Tube Length (in)	Dimension A (in)	Dimension B (in)	Tube Color	BQM Per media	
MTAI	20.157 ± 0.04	0.580 ± 0.005	0.200 ± 0.01	Clear	47	
KYE	N/A					



Pre and Post Change Summary – Tube Packing Method







QUALIFICATION REPORT SUMMARY

PCN #: JAON-24XWVA797

Date September 23, 2021

Qualification of MTAI as an additional final test site for selected SST26VF064B, and SST26VF064BA device families available in 16L SOIC (0.300in) package.

Purpose: Qualification of MTAI as an additional final test site for selected SST26VF064B,

and SST26VF064BA device families available in 16L SOIC (0.300in) package.

CCB No.: 4823

Test / Evaluation	Test Conditions / Parameters	Results
Destination Final Test Site Correlation	1.5K units through flow 100% FT_KGD@25C at MTAI Acceptance: Production Yield 100% QCP@25C at MTAI Acceptance: zero failure or reasonable Electrical Failure Analysis (EFA)	Passed